

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination YAMADA ET AL.	
			Examiner James W. Taylor, II	Art Unit 4171	Page 1 of 1

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V	Patent Abstracts of Japan for JP2005-336365A published on December 8, 2005.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
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